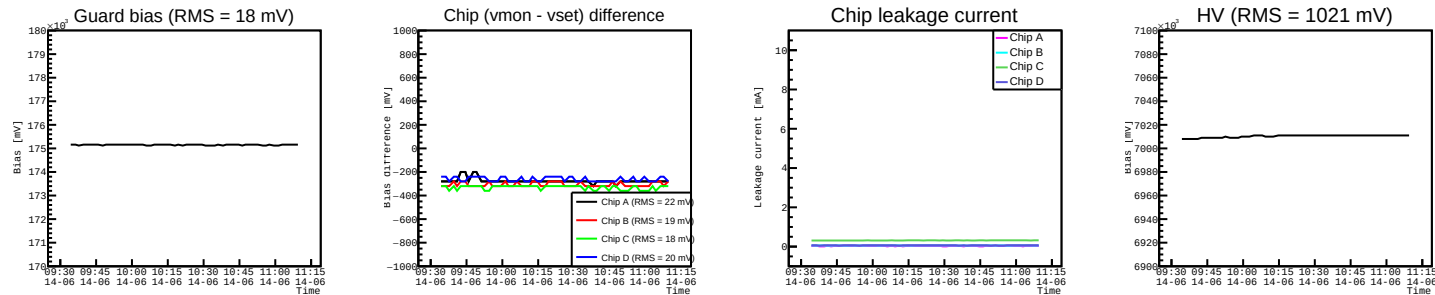


End of measuring: Tue Jun 14 12:55:47 2016

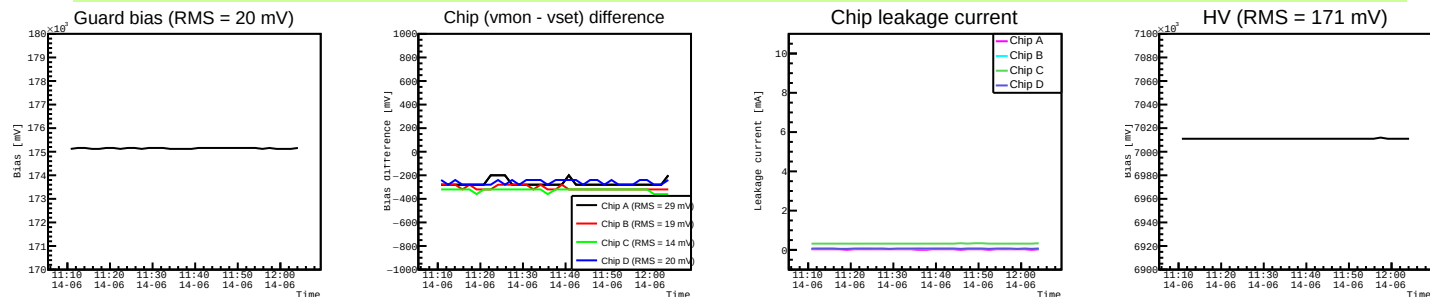
Threshold and Waveform

Tue Jun 14 09:34:22 2016



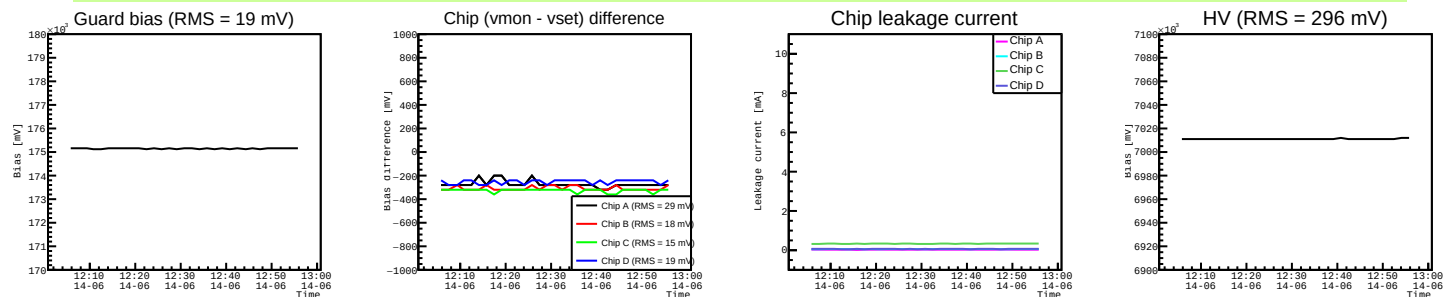
2D in X

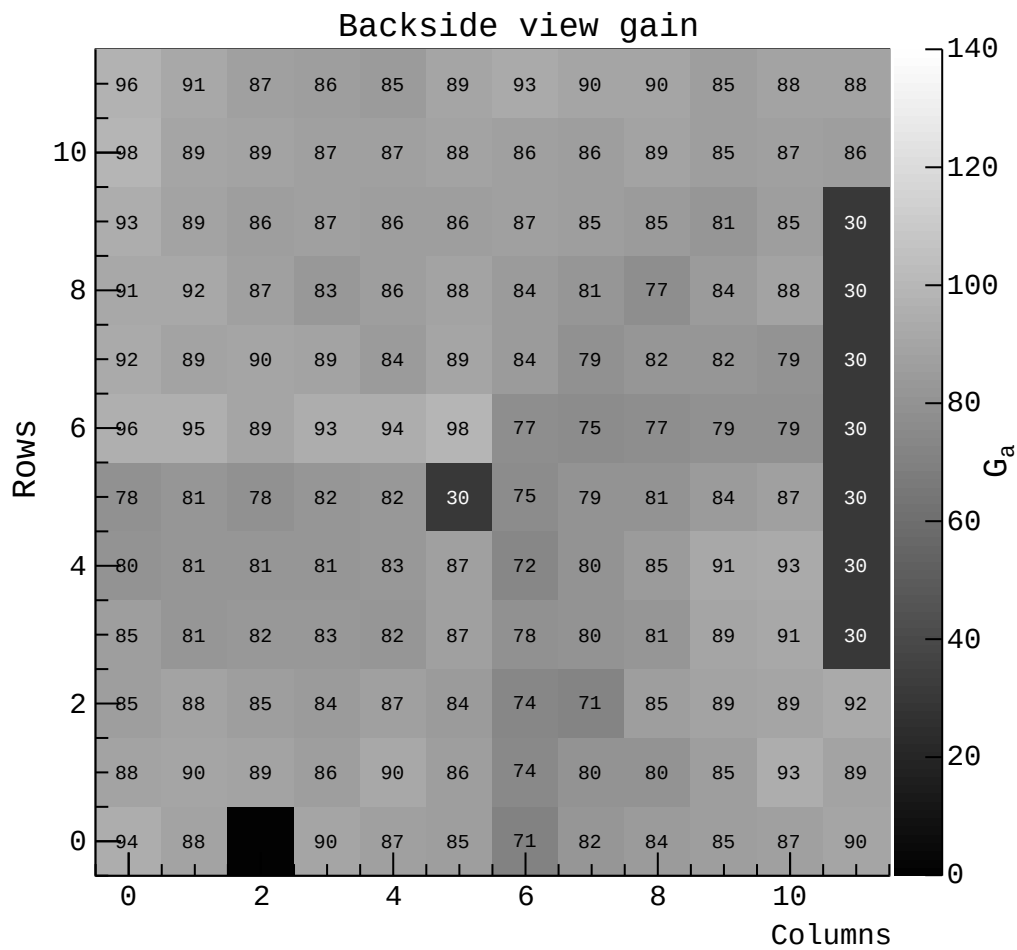
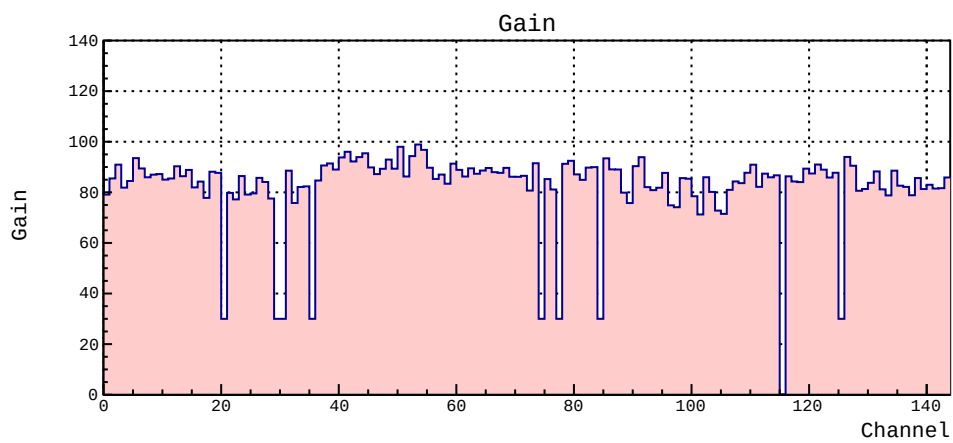
Tue Jun 14 11:10:47 2016



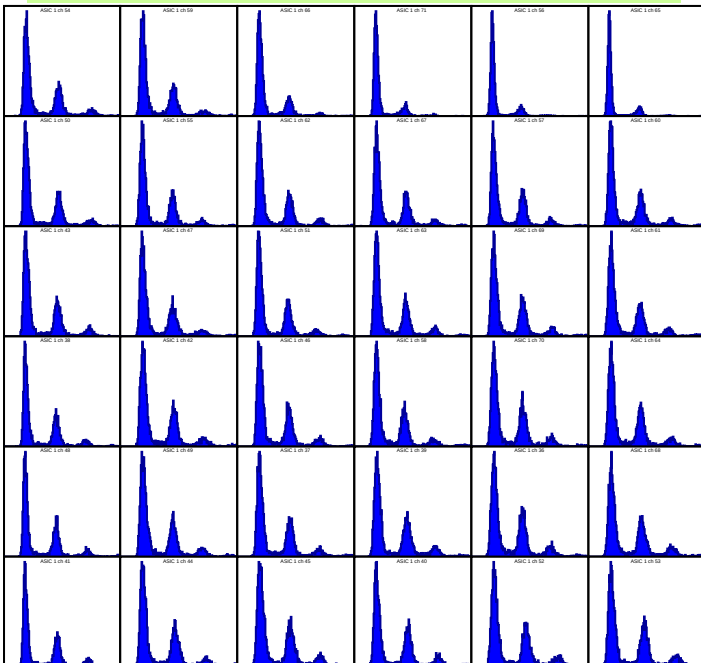
2D in Y

Tue Jun 14 12:05:48 2016

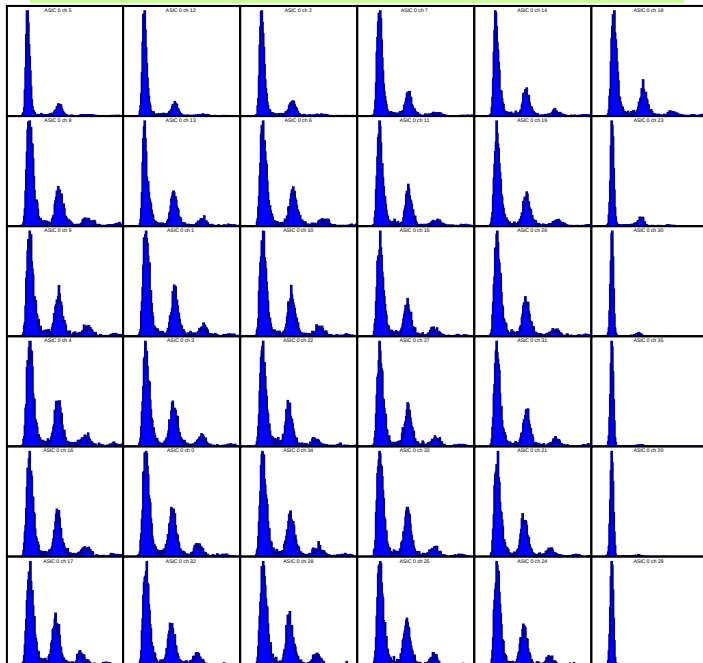




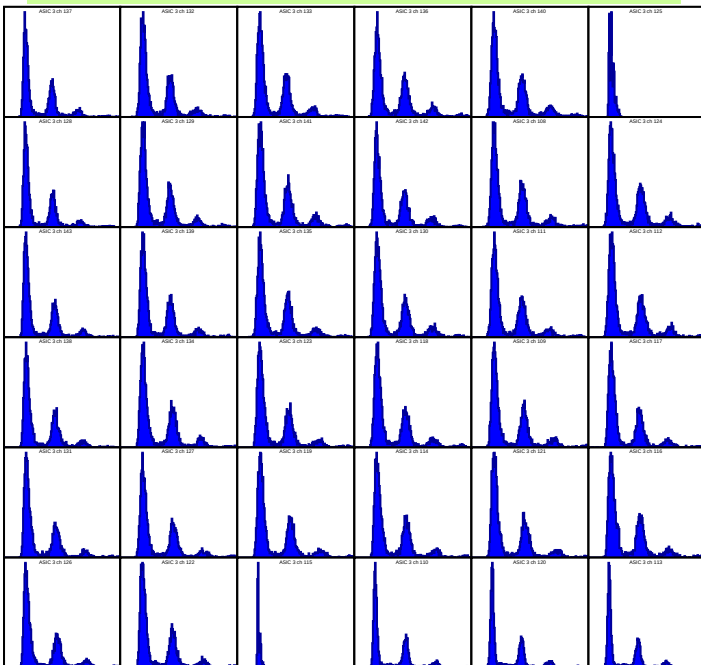
Charge scan over center of channels: Chip B



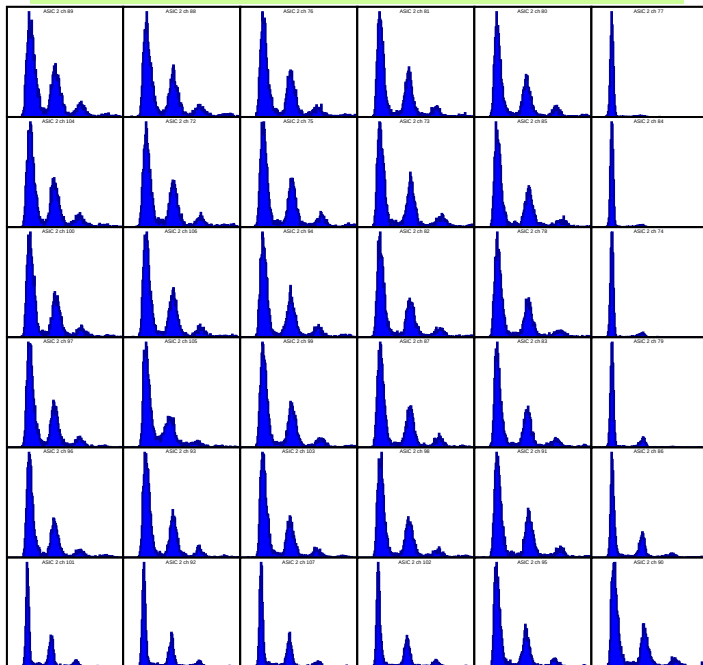
Charge scan over center of channels: Chip A



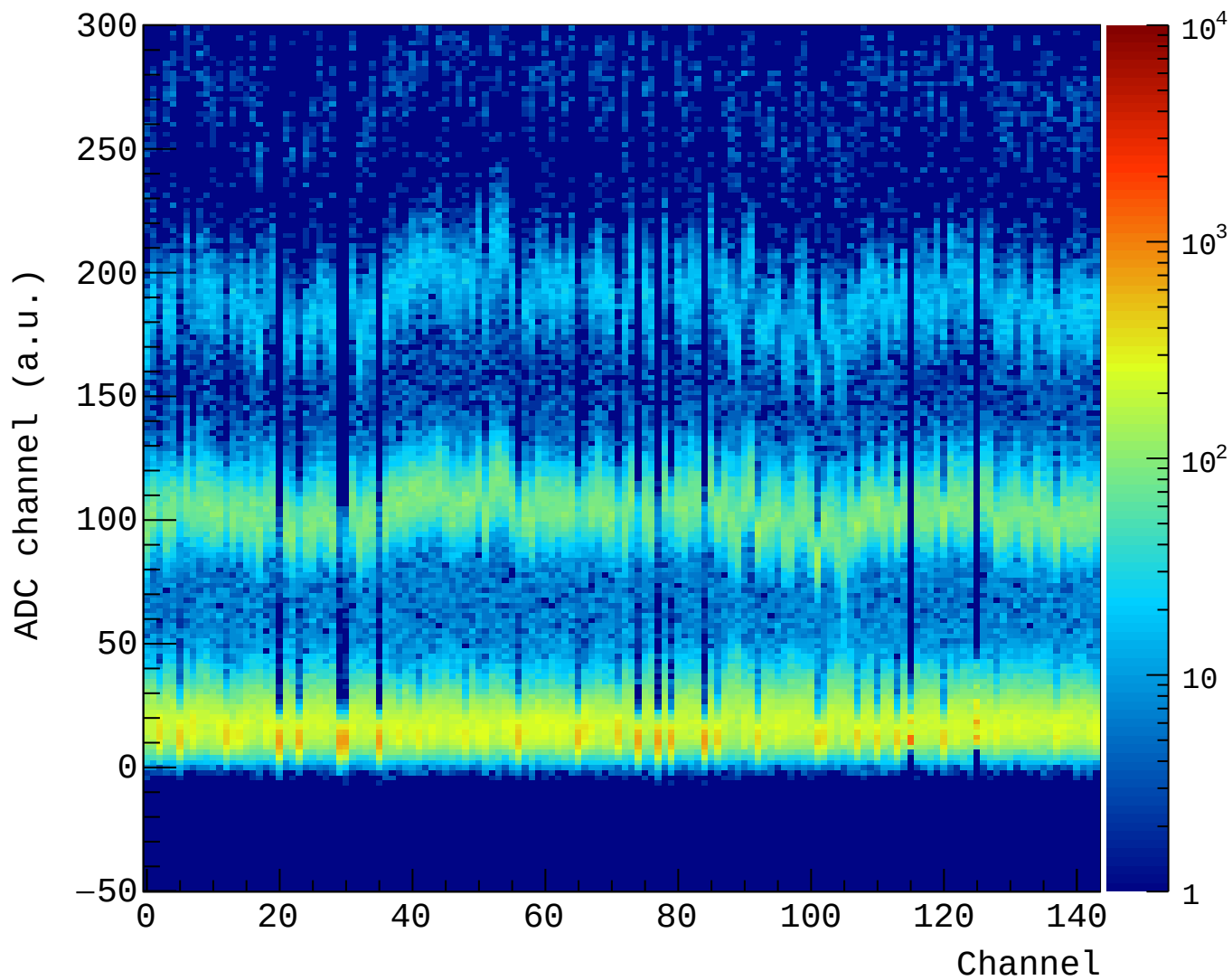
Charge scan over center of channels: Chip C



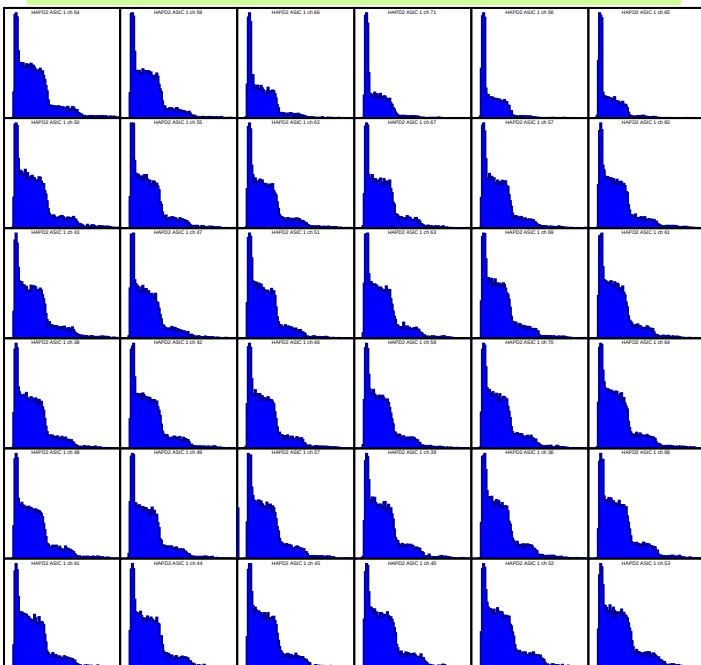
Charge scan over center of channels: Chip D



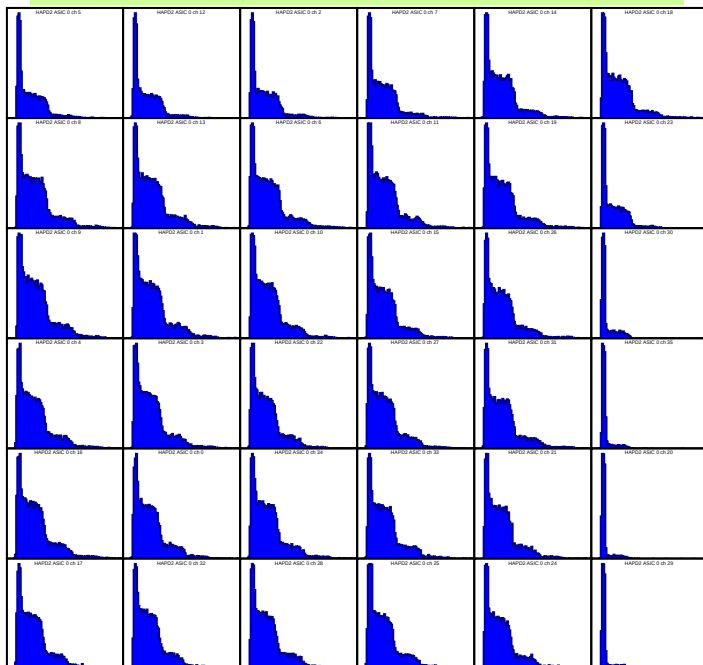
Charge scan over the center of channels



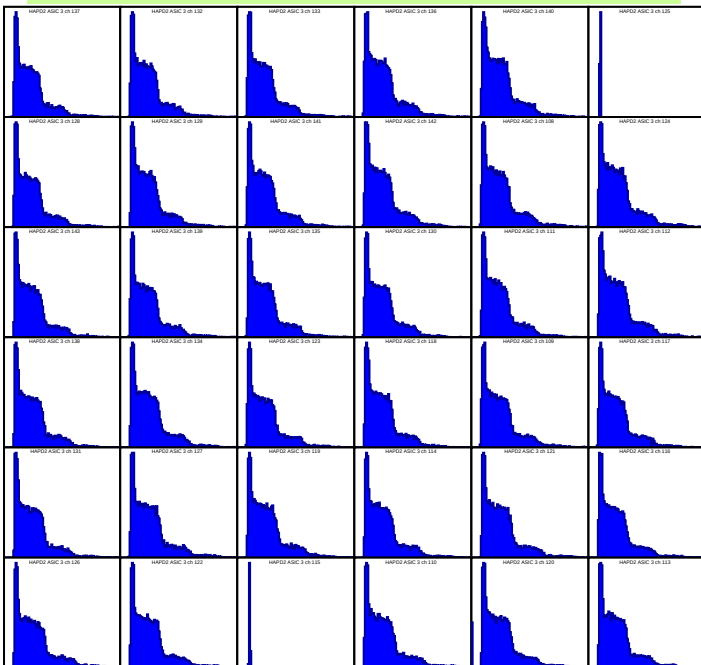
Threshold scan over center of channels: Chip B



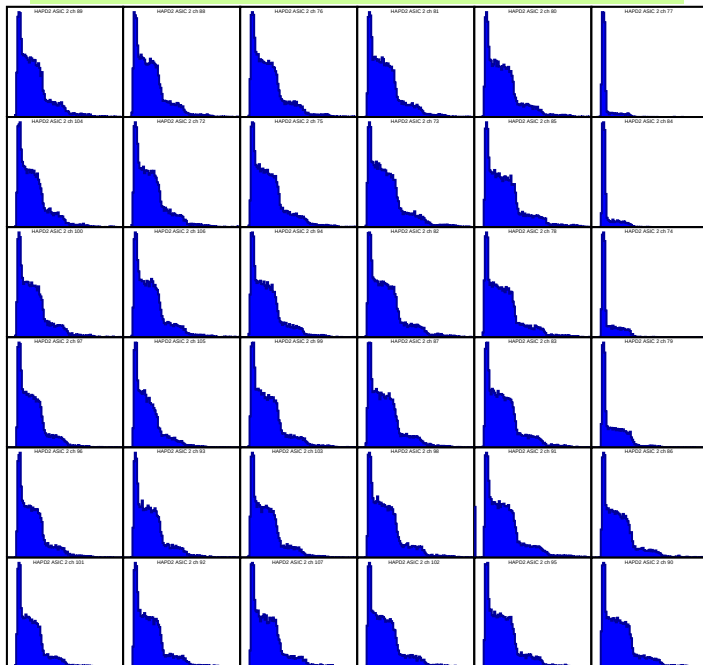
Threshold scan over center of channels: Chip A



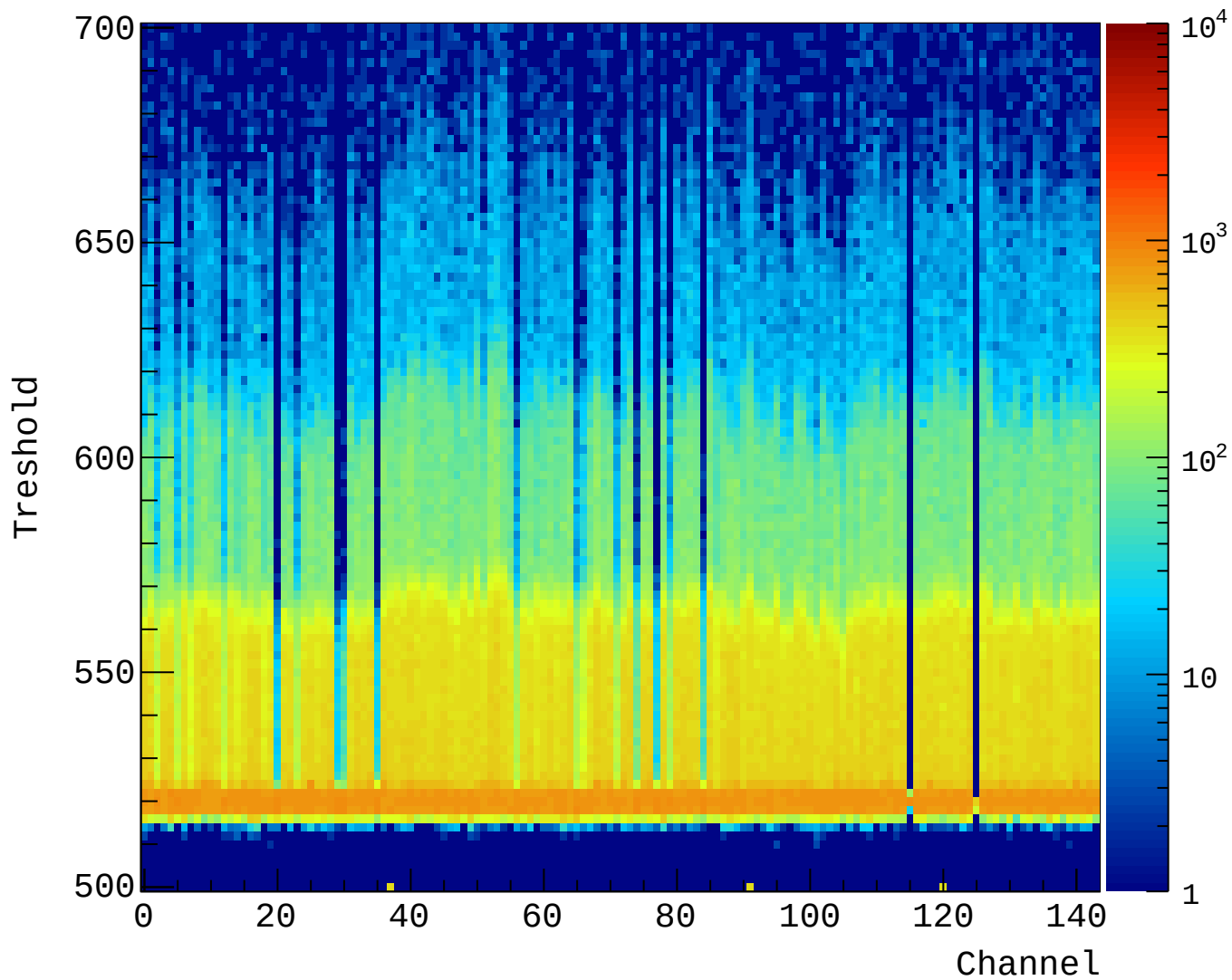
Threshold scan over center of channels: Chip C



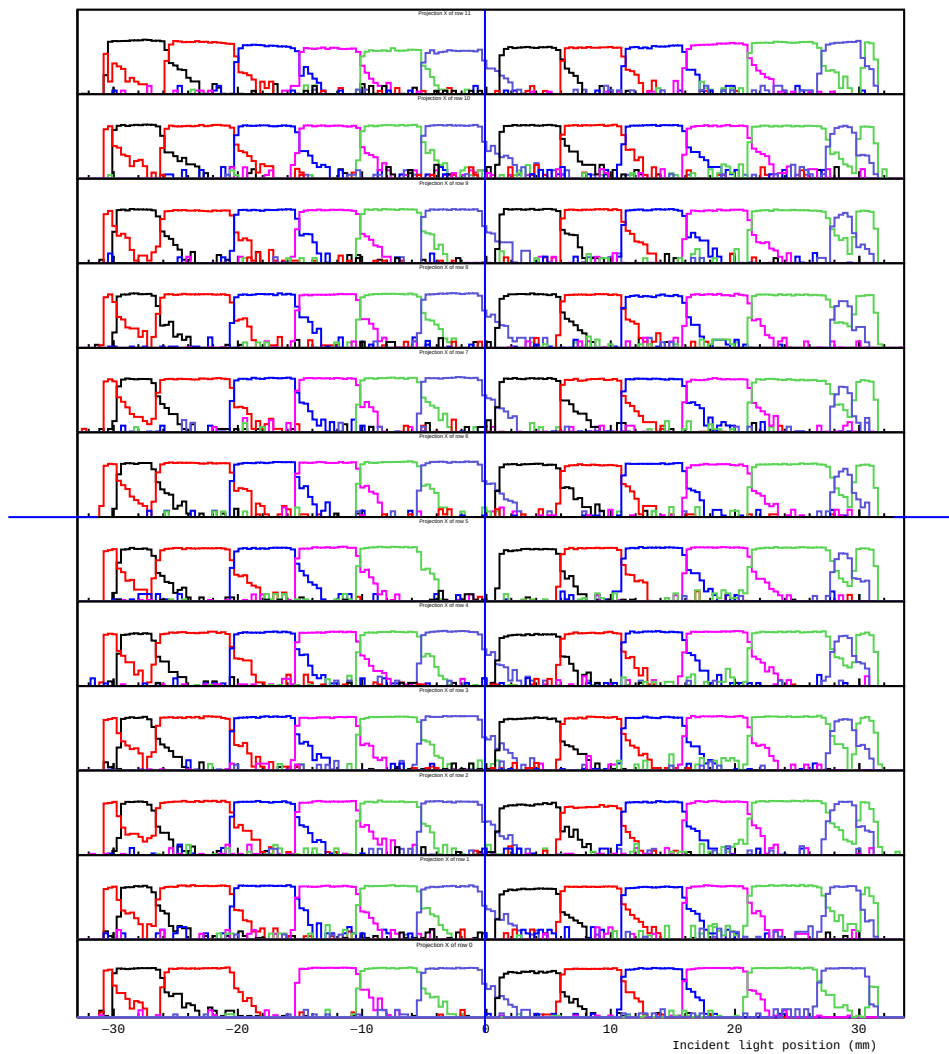
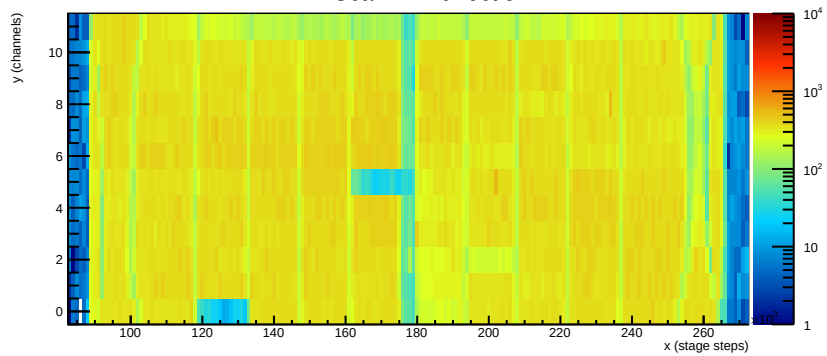
Threshold scan over center of channels: Chip D

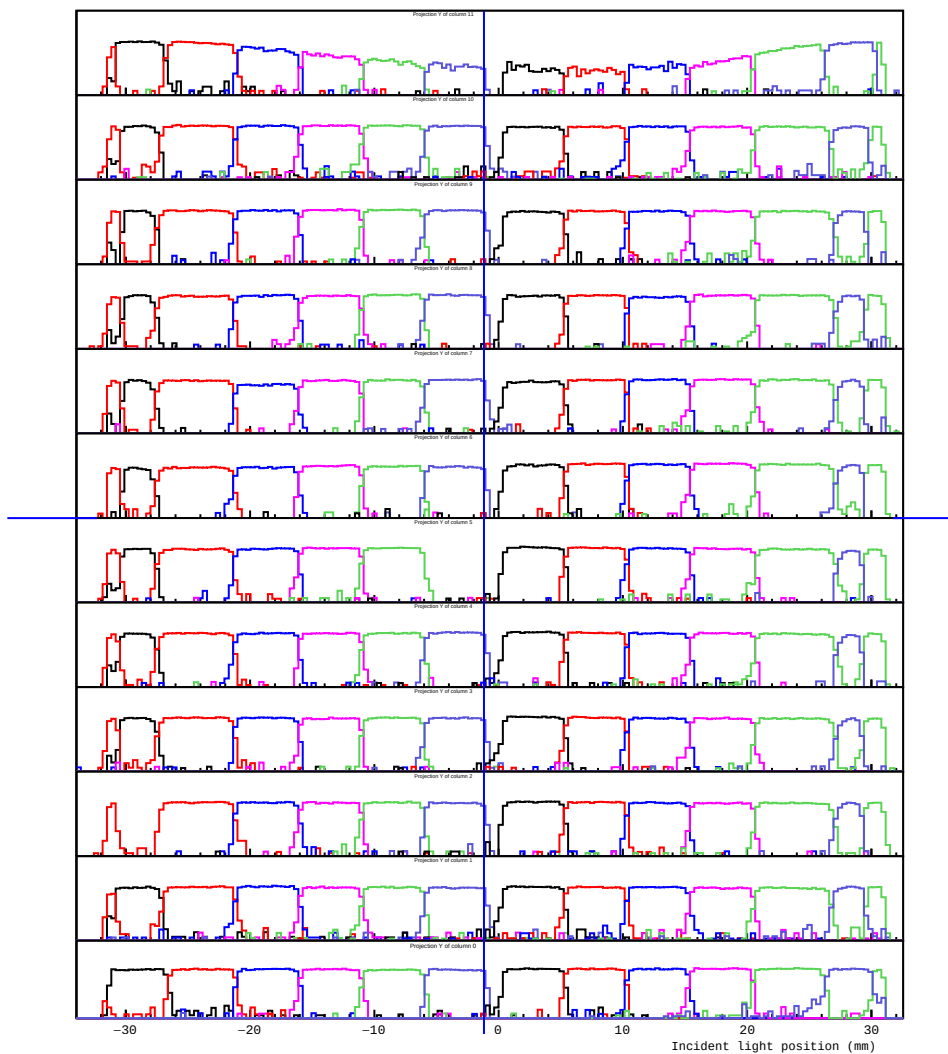
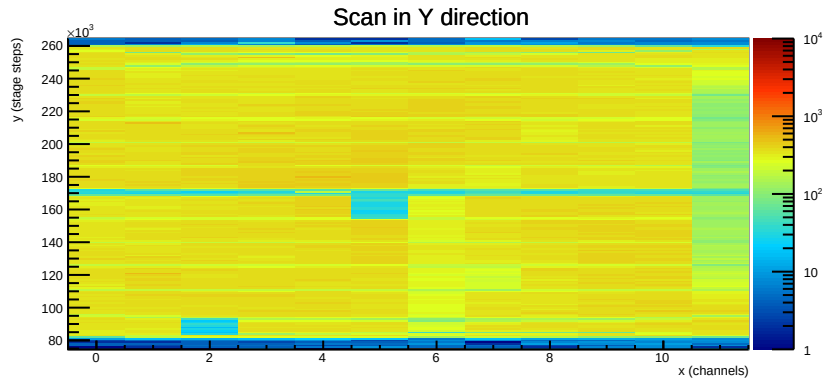


Threshold scan over the center of channels

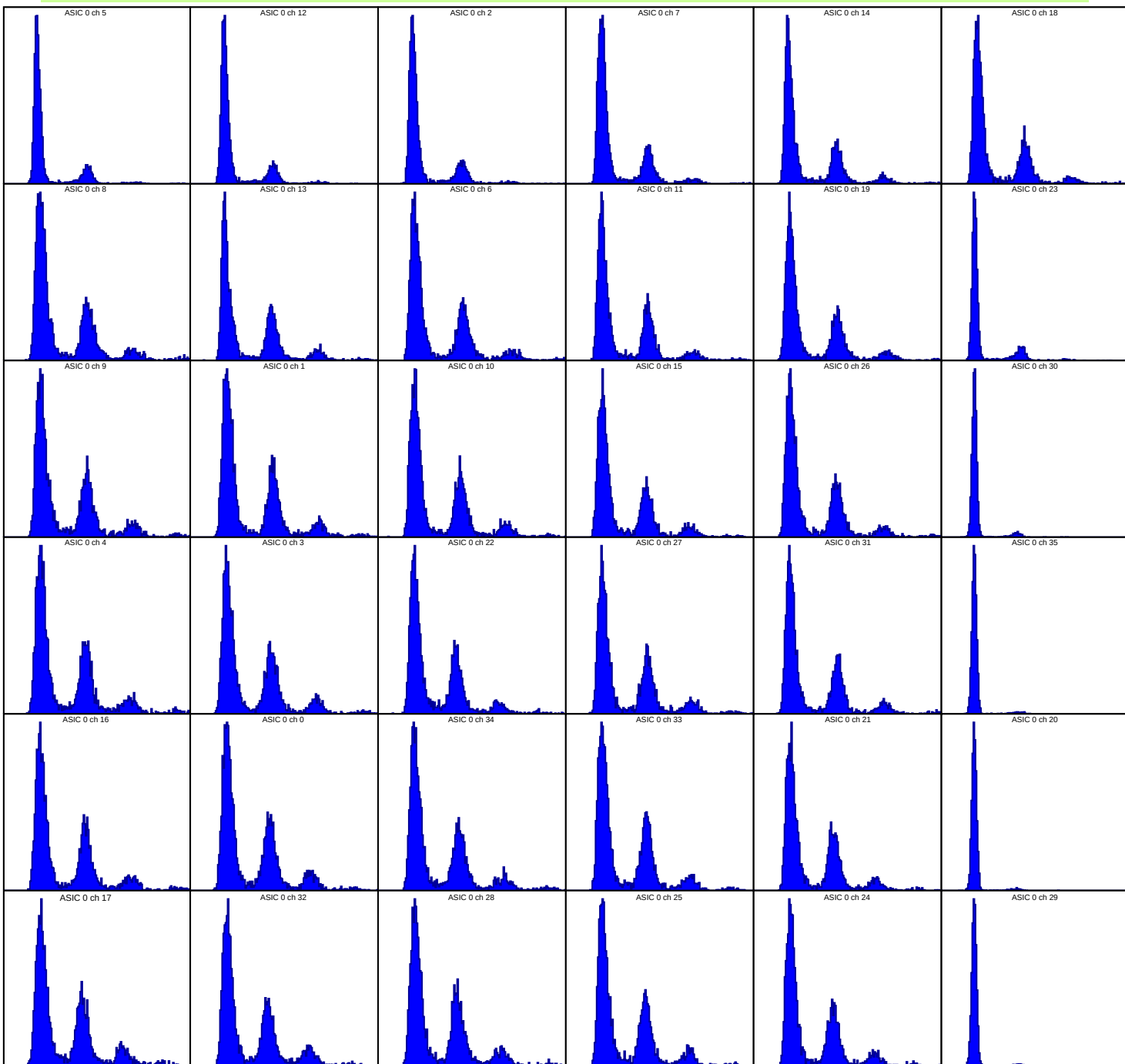


Scan in X direction

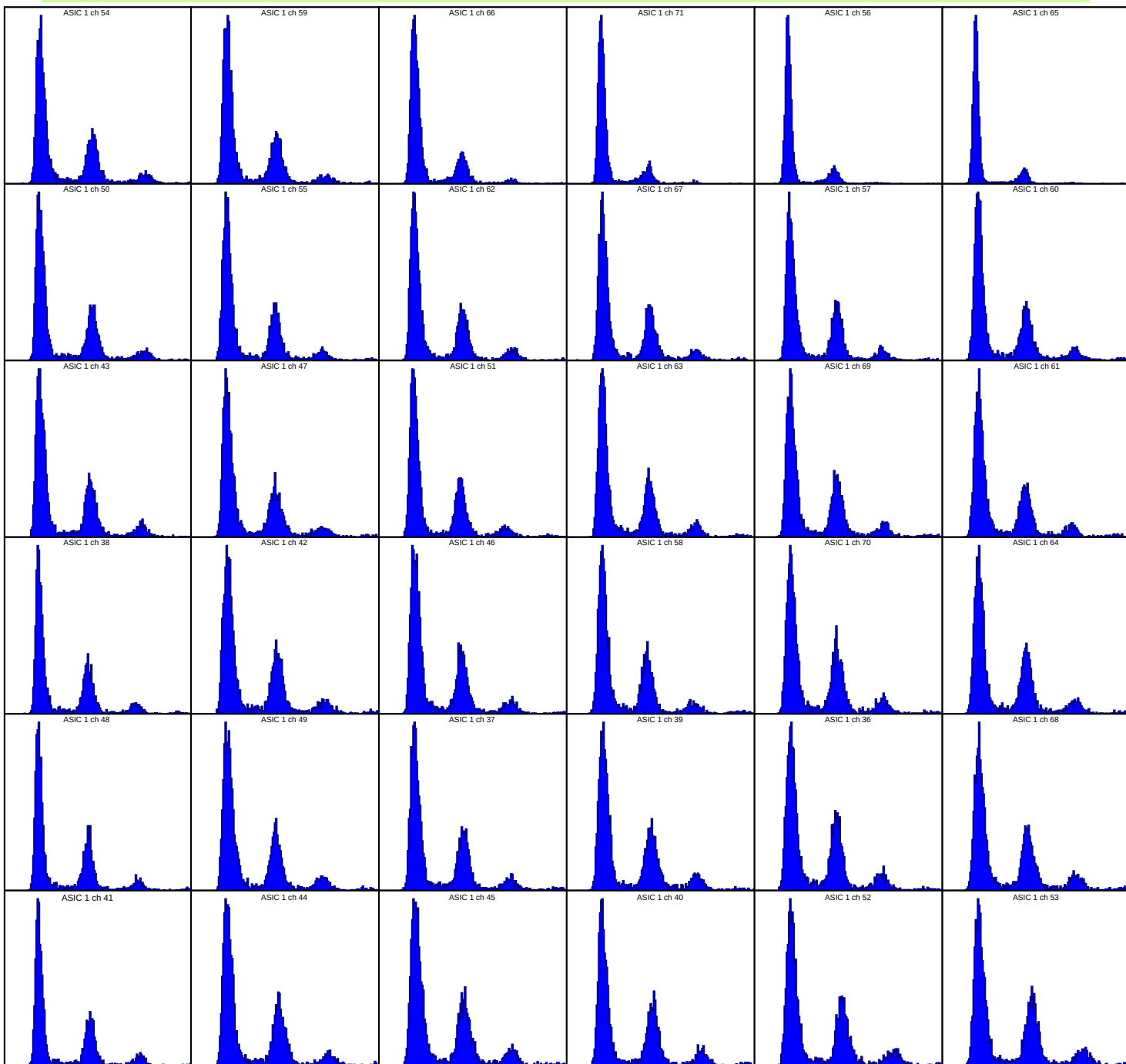




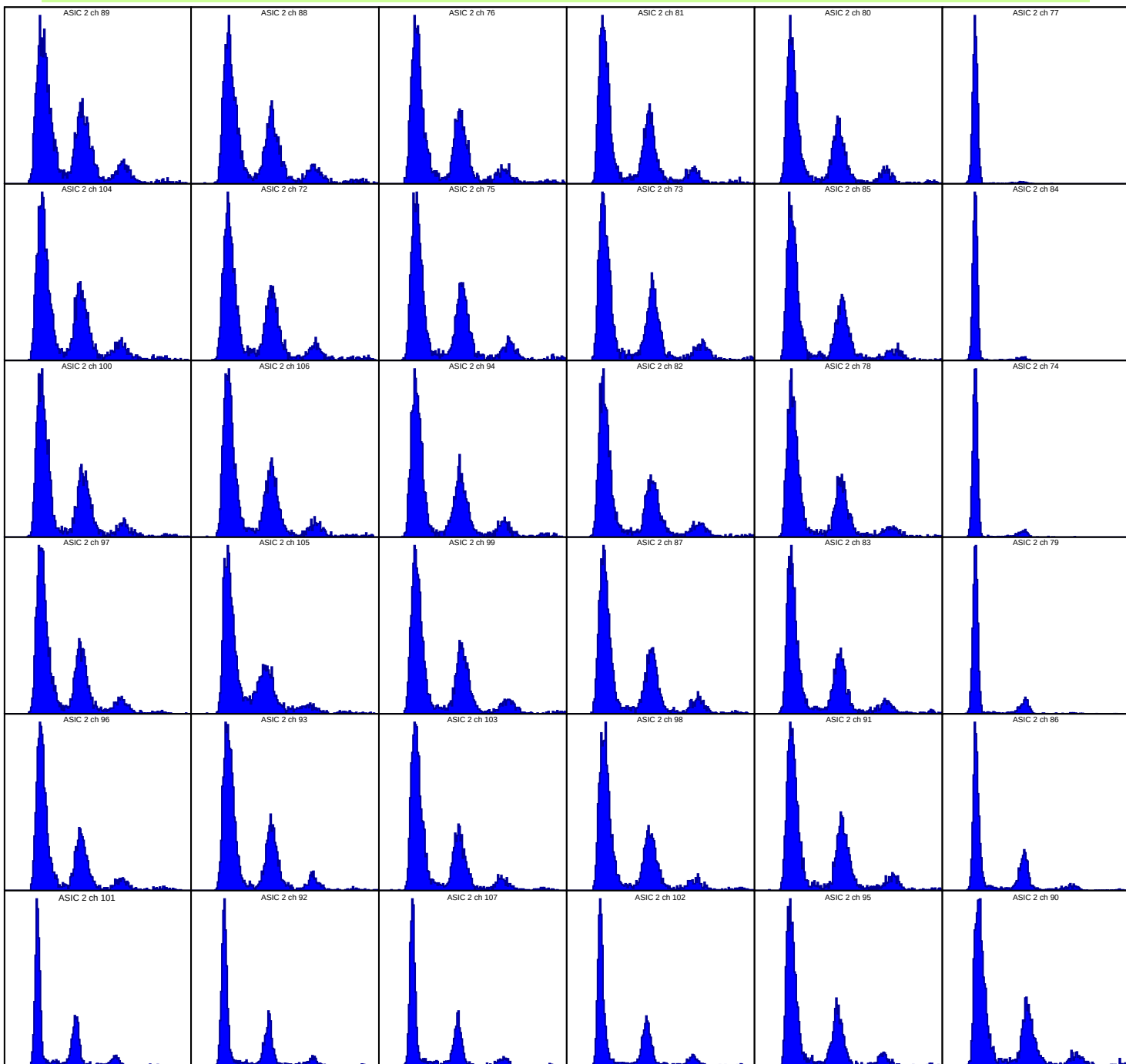
Charge scan over center of channels: Chip A



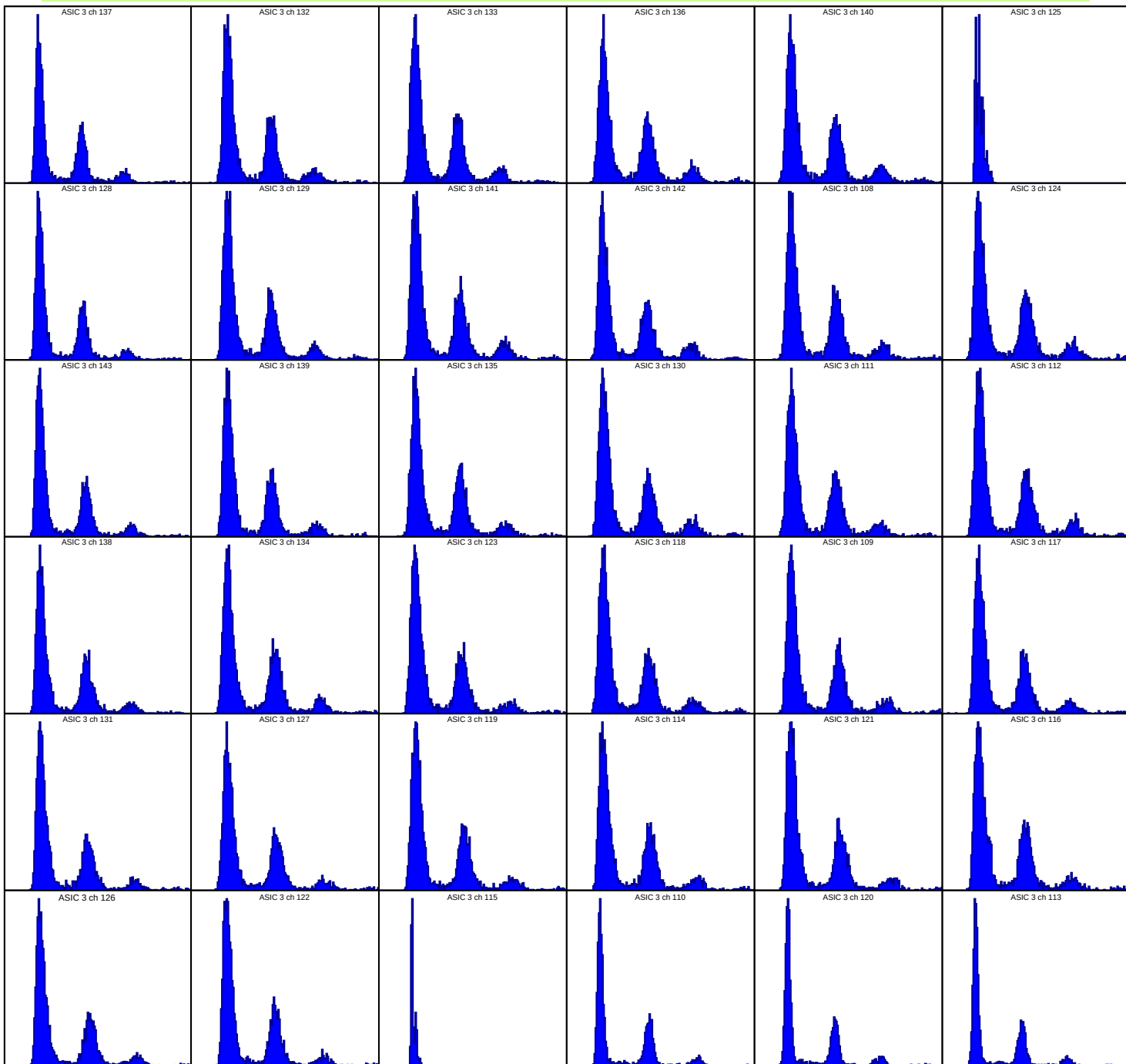
Charge scan over center of channels: Chip B



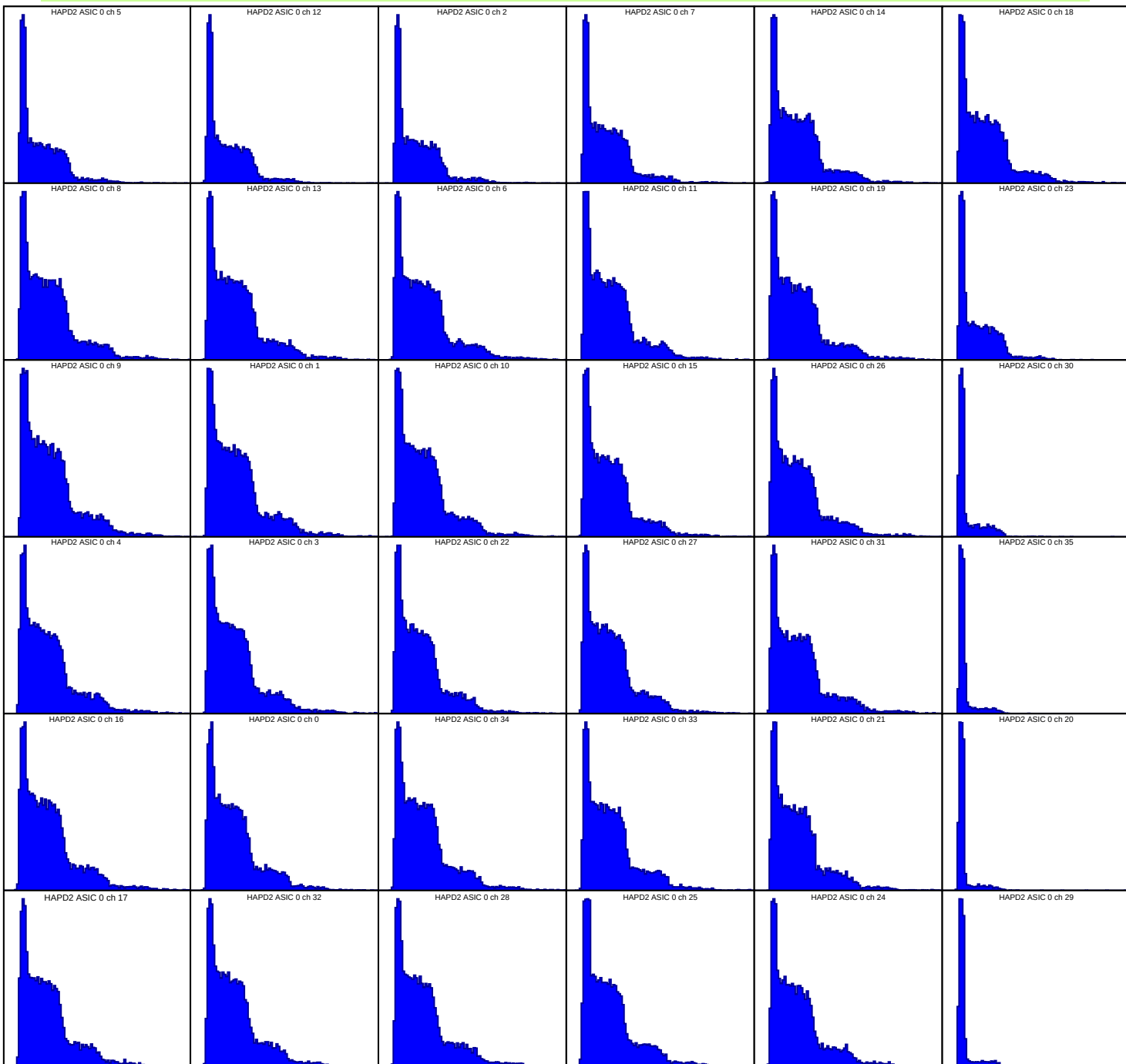
Charge scan over center of channels: Chip D



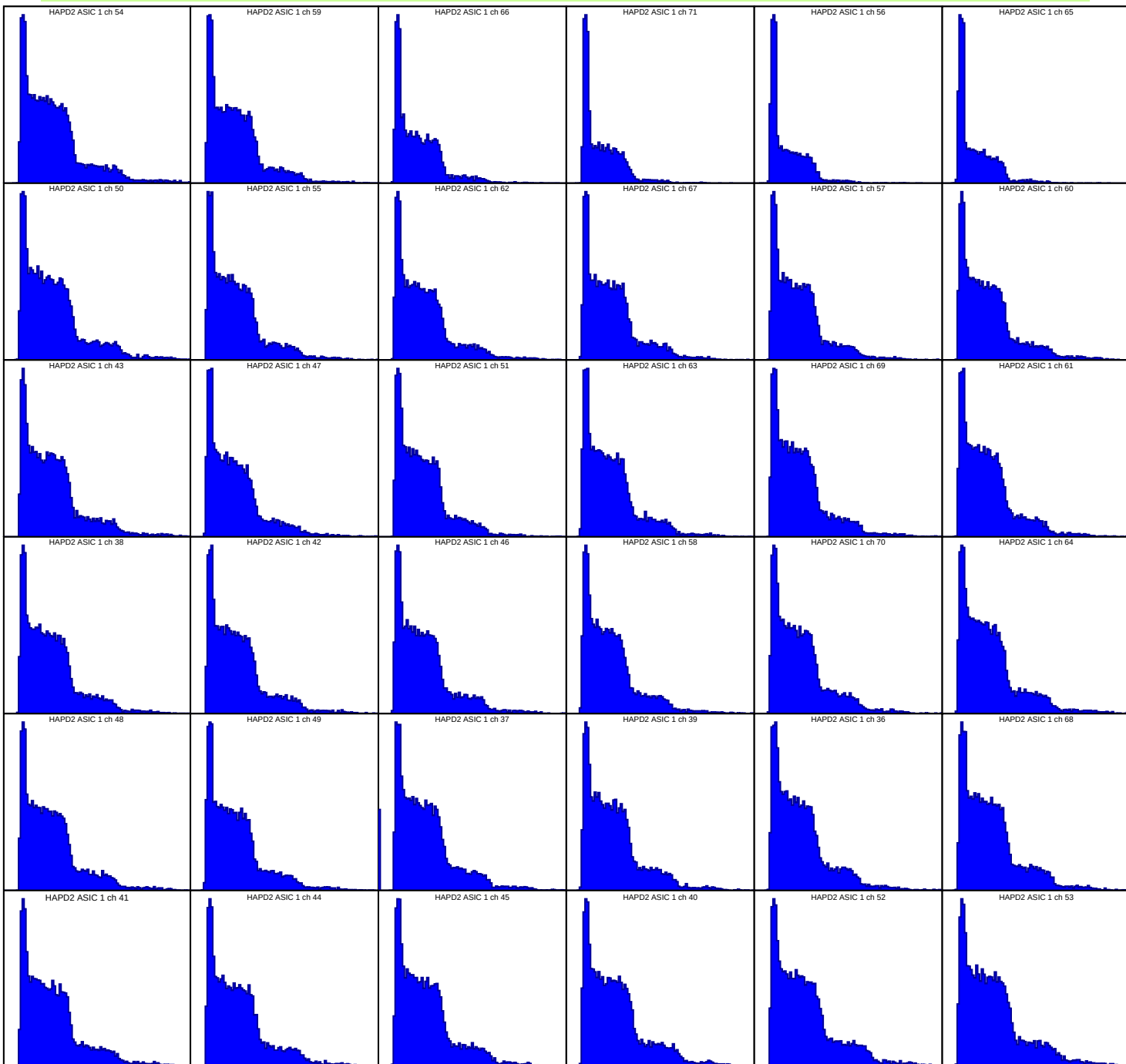
Charge scan over center of channels: Chip C



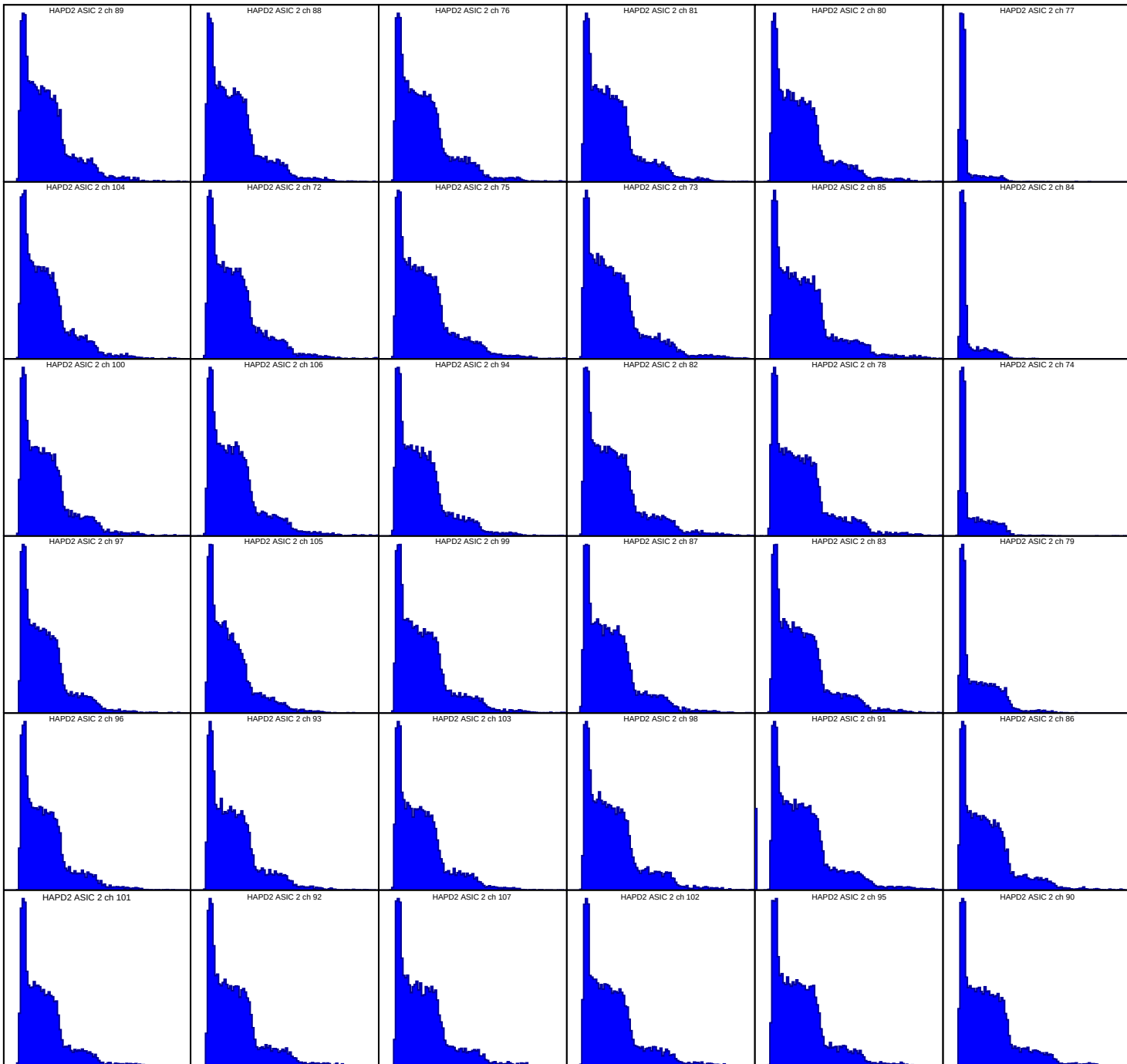
Treshold scan over center of channels: Chip A



Treshold scan over center of channels: Chip B



Treshhold scan over center of channels: Chip D



Treshold scan over center of channels: Chip C

